



## SLOVENSKI STANDARD

**SIST ISO 2808:1998**

**01-maj-1998**

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Paints and varnishes -- Determination of film thickness

Peintures et vernis -- Détermination de l'épaisseur du feuil

**PREVIEW**

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Ta slovenski standard je istoveten z: ISO 2808:1997

[SIST ISO 2808:1998](#)

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**ICS:**

87.040

Barve in laki

Paints and varnishes

**SIST ISO 2808:1998**

**en**

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# INTERNATIONAL STANDARD

ISO  
2808

Third edition  
1997-09-15

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## Paints and varnishes — Determination of film thickness

*Peintures et vernis — Détermination de l'épaisseur du feuil*

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Reference number  
ISO 2808:1997(E)

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## Foreword

ISO (the International Organization for Standardization) is a worldwide federation of national standards bodies (ISO member bodies). The work of preparing International Standards is normally carried out through ISO technical committees. Each member body interested in a subject for which a technical committee has been established has the right to be represented on that committee. International organizations, governmental and non-governmental, in liaison with ISO, also take part in the work. ISO collaborates closely with the International Electrotechnical Commission (IEC) on all matters of electrotechnical standardization.

Draft International Standards adopted by the technical committees are circulated to the member bodies for voting. Publication as an International Standard requires approval by at least 75 % of the member bodies casting a vote.

## iTeh STANDARD PREVIEW

International Standard ISO 2808 was prepared by Technical Committee ISO/TC 35, *Paints and varnishes*, Subcommittee SC 9, *General test methods for paints and varnishes*.

This third edition cancels and replaces the second edition (ISO 2808:1991) of which it constitutes a technical revision.  
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The main technical changes are:

- a) Addition of the following methods of film thickness determination:
  - 1) Gravimetric (dissolving) method (Method 9)
  - 2) Determination of dry-film thickness on blast-cleaned steel substrates (Method 10).
- b) Table 1 includes typical instrument bias and precision for each method.

Annex A forms an integral part of this International Standard.

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# Paints and varnishes — Determination of film thickness

## 1 Scope

This International Standard reviews and specifies a number of methods that are applicable to the measurement of the thickness of organic coatings applied to a substrate. It does not apply to metallic coatings. Some of the techniques described can be adapted for the measurement of the thickness of detached coatings. The principles of the methods, their particular field of application and the expected precision are given in table 1.

This International Standard also defines terms concerning the determination of film thickness.

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**Table 1 - Methods of film thickness measurement**

Note 1: Many of the methods referred to below may be adapted for use with detached films.

Number and description	Techniques and applications	Typical instrument bias <sup>1)</sup> and precision	Remarks
Method No. 1 <b>iTeh STANDARD REVIEW</b> A Comb gauge (standards.itech.ai)	<p>Assessment of wet-film thickness</p> <p>B Wheel gauge <a href="https://standards.itech.ai/catalog/standards/sist/6700fcf5-53ca-418d-aecd-9cb431f76a79/sist-iso-2808-1998">https://standards.itech.ai/catalog/standards/sist/6700fcf5-53ca-418d-aecd-9cb431f76a79/sist-iso-2808-1998</a></p> <p>C By weighing</p> <p>For measurement of wet-film thickness of freshly painted surfaces.</p>	<p>Bias: <math>\pm 2,5\%</math> + 1 <math>\mu\text{m}</math></p> <p>Reproducibility: <math>\pm 15\text{ }\mu\text{m}</math></p>	<p>Measurements give an approximate indication of the thickness of the wet film.</p> <p>May be used in laboratories and on site.</p> <p>Method 1C may also be used for determining the dry-film thickness, but in the laboratory only.</p>
Method No. 2	<p>For use on films too soft to be measured by methods which use a presser foot or probe.</p> <p>Determination of dry-film thickness by calculation from the ratio of dry-film mass to dry-film area</p>	<p>Determinations are not precise</p>	<p>Provides a check that the mean thickness lies between specified limits. The film remains undamaged.</p>

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### Method No. 3

Measurement of dry-film thickness by mechanically contacting instruments

A Micrometer method. For use on test panels or painted surfaces that are substantially plane.

Bias:  $\pm 2 \mu\text{m}$   
Reproducibility:  $\pm 30\%$  for low and  $20\%$  for higher film thicknesses

The film has to be hard enough to resist indentation on closing the micrometer jaws. The film is damaged in the test. The film thickness shall be greater than  $25 \mu\text{m}$  unless the film is detached.

B Dial gauge method  
Test panels or painted surfaces that are substantially plane or have a curvature in one direction

Reproducibility:  $\pm 10\%$ , with a lower limit of  $2 \mu\text{m}$

The film has to be hard enough to resist indentation on lowering the gauge or electric-device presser foot.

### Method No. 4

Measurement of dry-film thickness by the profilometric method

Recommended as a referee method for painted surfaces that are substantially plane.

Reproducibility:  $\pm 10\%$ , with a lower limit of  $2 \mu\text{m}$

The film has to be hard enough to resist indentation by the profile-tracing stylus. The film is damaged in the test.

**Method No. 5**

A Microscopic examination of cross-section.  
Measurement of dry-film thickness by microscope methods  
Recommended as a referee method for films on substrates of varying profile, for example grit-blasted surfaces.

**iTeh STANDARDED REVIEW****(standardized method)**

B Wedge cut method.  
Not applicable to brittle or friable films.  
[ISO 2808:1998](https://www.iso.org/standard/67000.html)  
[https://standards.iehl.ai/catalog/standards/iso/67000/fcd5-53ca-418d-aecd-90b43117\\_0a75f310-2007-12-28](https://standards.iehl.ai/catalog/standards/iso/67000/fcd5-53ca-418d-aecd-90b43117_0a75f310-2007-12-28)

Bias: 2 µm  
Reproducibility: ± 10 %

A portion of the painted article is cut out and mounted in resin.  
The film is damaged in the test.

C Surface profile measuring method. Applies to transparent films and to films which can be cleanly removed from the substrate.

Reproducibility: ± 10 %

A special cutting tool or paint borer is required to cut through the film.  
The film is damaged in the test.

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### Method No. 6

For magnetic metallic substrates

A Magnetic-induction principle  
 Bias:  $\pm 2\% + 1 \mu\text{m}$   
 Reproducibility:  $\pm 10\%$   
 The film has to be hard enough  
 to withstand the pressure of the  
 probe.  
 May be used on site.

B Permanent-magnet pull-off principle  
 Bias:  $\pm 5\% + 1 \mu\text{m}$

For non-magnetic metallic substrates

Bias:  $\pm 2\% + 1 \mu\text{m}$

Instruments operate on the  
 eddy-current principle.

Reproducibility:  $\pm 10\%$   
 The film has to be hard enough to  
 withstand the pressure of the  
 probe.

Eddy current method

May be used on site.

Instruments operate on the beta-particle back-scatter principle (method No. 8A) or the X-ray fluorescence principle (method No. 8B).

Used when contact by the measuring instrument with the coating needs to be avoided.  
Applicable to painted surfaces which are substantially flat.

Reproducibility:  $\pm 10\%$

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**Method No. 8**  
Applicable to films on substrates

of varying profiles, for example grit-blasted steel panels, and to films on polymeric substrates if the substrate is not affected by the paint solvent.

Paint films have to be homogeneous for measurements to be accurate.

The coating mass is determined by dissolving the coating without dissolving the substrate. The mass of coating divided by the density and the area of the coating gives the average coating thickness.

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Method No. 10

For dry coatings on magnetic  
metallic substrates having a  
rough (blast-cleaned) surface.

Determination of dry-film  
thickness on blast-cleaned steel  
substrates

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Instruments operate on the  
magnetic-induction principle.

May be used on site.  
In some cases, method No. 5A or  
method No. 9 may also be used.

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1) The bias data are based on  
information supplied by the  
instrument manufacturers